





Test report of

In Situ Temperature Measurement

And Lumen Maintenance Projection

Rendered to:

LIGHT EFFICIENT DESIGN, DIV OF TADD LLC. 188 S. Northwest Highway Cary, IL 60013

For products: LED Lamp

Models:

LED-8030M50-MHBC

Test date: Sep. 17, 2016

Test laboratory: LCTECH (Zhongshan) Testing Service Co.,Ltd

2/F., Technology and Enterprise Development Center, Guangyuan Road, Xiaolan,

Zhongshan, Guangdong, China

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Sep. 27, 2016

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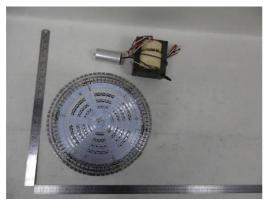
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1 General

1.1 Products Information

Brand Name	-
Lamp Type	LED Lamp
Model Number	LED-8030M50-MHBC
Rated Inputs	277V, 60Hz
Rated Power	210 W
Rated Initial Lamp Lumens	N/A
Declared CCT	5000K
Ballast	M59
LED Package, Array or Module	Model: SPMWHX1228FXXXXXXXX, manufactured by SAMSUNG
	ELECTRONICS CO., LTD
Date of Receipt Samples	Sep. 7, 2016
Quantity of Receipt Samples	1 units

Photo





Picture 1 Picture 2





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1.2 Reference standards or methods

The following standards are partly or totally used or referenced for test:

No.	Name
IEC 62560-2011#	Self-ballasted LED-lamps for general lighting services by
	voltage>50V- Safety specifications
IES LM-80-08	Approved Method for Measuring Lumen Maintenance of LED Light
	Sources
IES TM-21-2011	Projecting Long Term Lumen Maintenance of LED Sources
IES LM-84-14 Annex A	Recommendations for measurement of In-situ conditions LED
	case Temperature, Ts

^{**}Note: Standard IEC 62560-2011 only clause 10 cap temperature rise was tested . For reference only and IEC 62560-2011 is not in the scope of NVLAP recognition.

1.3 Equipment list

ID	Instrument	Model name	Cal. Date	Next cal. Date
AC Power supply	LC-I-923	CHP-500	2016-02-04	2017-02-03
AC Power supply	LC-I-987	APW-110N	2016-02-04	2017-02-03
Power analyzer	LC-I-954	WT210	2016-02-04	2017-02-03
Multimeter	LC-I-972	Fluke 17B	2016-08-10	2017-08-09
J thermocouple	LC-I-096	TT-J-30-SLE(200m/r)	2016-03-01	2017-02-28
Data acquisition/Switch unit	LC-I-098	34970A	2016-03-01	2017-02-28
Wireless T&H Transmitter	LC-I-978	DWRF-B	2016-02-03	2017-02-28





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2 Test conducted and method

2.1 Ambient Condition

Test was conducted in an ambient temperature of 25 \pm 5 °C. Ambient temperature variations above or below 25 °C was subtracted from or added to temperatures recorded at points on the luminaire. The ambient temperature was measured by a thermocouple which was immersed in 15 ml of mineral oil

2.2 Temperature Stabilization

Temperatures were measured after they have stabilized when the temperature were changing at a rate less than 1°C per hour and would not rise.

2.3 Thermocouples

in a glass container.

Type J thermocouple was used for temperature measurement. The diameter of thermocouple conductor was 0.05mm².

2.4 Draught-free test enclosure

The lamp was positioned in a rectangular draught-proof enclosure with a double skin on the top and on at least three sides, and with a solid base. The double skins were of perforated metal, spaced apart approximately 150mm, with regular perforations of 1 mm to 2 mm diameter, occupying about 40% of the whole area of each skin. The internal surfaces of enclosure are painted with a matt paint.

2.5 Suspension methods

The luminaire was suspended in the ceiling of draught-free test enclosure.

2.6 Thermocouples contact

Thermocouples were in contact with the TMP_{LED} location described in LM-80 test report. In order to gain the maximum temperature, if appropriate, more than one thermocouple was contact in these locations. For details information, please refer to clause 3.3 for the photo of thermocouple contact.





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3 Test Result

3.1 Electrical data

Criteria Item	Result
Input voltage	276.99V~60Hz
Input current	1.300
Total power	212.12
Power factor	0.589

3.2 Temperature data

Criteria Item	Result
Total operated period	8.0 hours
Ambient temperature	24.8°C
Measured maximum Temperature @TMP _{LED}	73.9°C
Maximum Temperature @TMP _{LED} (Normalized to 25°C)	<u>73.5°C</u>

Note: TMP_{LED} was the maximum temperature LED which was selected based on the method of Annex A of IES LM-84-14

3.3 Lumen Maintenance Projection (IESNA TM-21 Method)

Criteria Item	Result
10000 hours lumen maintenance of LED light source	94.21%
forward current on each LED light source	150 mA
Projected L ₇₀ lumen maintenance life	<u>51000 hours</u>
Reported L ₇₀ lumen maintenance life	<u>51000 hours</u>

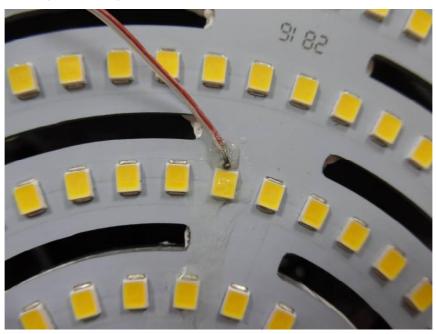
Note: Please refer to appendix 2 and 3 for details of TM-21 inputs and results.



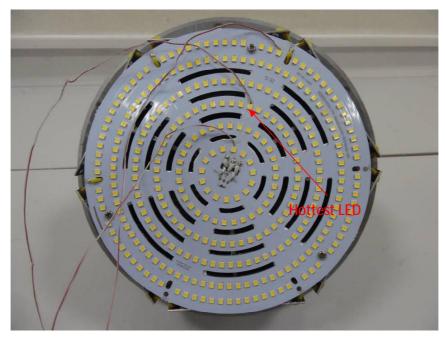


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3.4 Thermocouple contact photo



Picture 1 Part view of hottest LED



Picture 2 Over view





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Appendix 1 LM-80 report summary

Appoint X 1 Em 00 Topolitous	u. y		
Report originated by	Shenz	hen BST Technology Co.	, Ltd.
Manufactured by	SAMSU	JNG ELECTRONICS CO	., LTD
LM-80 report No.	BS	T1510440900002Y- 1SR	- 2
LED Model	SF	PMWHX1228FXXXXXXX	X
LED Part Number	SF	PMWHX1228FXXXXXXX	X
Number of LED light source tested		20 units	
Drive Current	150 mA		
Case temperature	55°C	55°C 75°C 85°C	
10000 hours lumen maintenance	94.20% 94.04% 90.57%		
10000 hours color	0.0042	0.0052	0.0059
maintenance(Δu'v')	0.0042	0.0052	0.0059



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Ref No

TM-21 Inputs

							I
		5	LM-80 Test Inputs				
Instructions	Description of LED Light Source Tested (manufacturer, model, catalog number)		Test Data for 55°C Case Temperature	Test Da	Fest Data for 85°C Case Temperature	Test Da T	Test Data for 105°C Case Temperature
Yellow fields are completed by the user. Fields not used should be left	Model: SPMWHX1228FXXXXXXXX, manufactured by SAMSUNG ELECTRONICS CO., LTD	SAMSUNG Time (hours)	Lumen Maintenance (%)	Time (hours)	Lumen Maintenance (%)	Time (hours)	Lumen Maintenance (%)
blank. Cyan fields are calculated		0	100,00%	. 0	100.00%	. 0	100,00%
200000000000000000000000000000000000000		1000	100.00%	1000	%06'66	1000	89.50%
First, enter a description of the LED		2000		2000	98.84%	2000	98.33%
light source tested. Then complete		3000		3000	98.26%	3000	97.35%
the fields labeled "LM-80 Testing		4000		4000	97.77%	4000	96.44%
Details" Test duration must be at	LM-80 Testing Details	2000		2000	97.36%	2000	95.63%
least 6,000 hours. If only one case	Total number of units tested per case temperature:	20 6000	97.34%	0009	96.72%	0009	94.81%
temperature data set is to be used (no	Number of failures:	0 0 2000	%00'.26	7000	95.74%	7000	92.70%
interpolation), complete only "I ested	Number of units measured:	20 8000	96.42%	8000	94.69%	8000	92.22%
case temperature data sets complete	Test duration (hours):	10000 9000	95.49%	0006	94.51%	0006	91.44%
1 and 2	Tested drive current (mA):	150 10000	94.20%	10000	94.04%	10000	90.57%
	Tested case temperature 1 (T _o , ⁰ C):	55					
Next, further to the right, in the	Tested case temperature 2 (T _c , ⁰ C):	85					
corresponding box(es) for each tested	Tested case temperature 3 (T _o , ⁰ C):	105					
case temperature, enter the test data							
along with the time (in hours) at which							
entered must be normalized then							
averaged measured data (per TM-21							
sections 5.2.1 and 5.2.2).							
Enter drive current, in-situ							
temperature data and the percentage of initial lumens to project to in the	In-Situ Inputs						
fields labeled "In-Situ Inputs".	Drive current for each	150					
Results can be tailored to estimate	LED package/array/module (mA):						
limen maintenance at a specific time	//n-s/ru case temperature (1°, ℃):	73.5					
by entering a value (t) in the yellow	Percentage of initial lumens to project to (e.g. for L.m. enter 70):	20					
TIERG.	.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,						
A complete TM-21 report will appear	Results						
on the next tab labeled "Report".	21 5000 To 10 10 10 10 10 10 10 10 10 10 10 10 10						
	Time (i) at which to estimate lumen maintenance (hours):	10,000					
	Lumen maintenance at time (t) (%):	94.21%					
	Calculated L70 (hours):	51,000					
	Reported L70 (hours):	51,000					

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Appendix 3 TM-21 Results

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LECH (ZHOWERE)

Ref



Model: SPMWHX1228FXXXXXXXX, manufactured t

Description of LED Light Source Tested (manufacturer, model,

catalog number)

Test Condition 2 - 85°C Case Temp

Test Condition 1 - 55°C Case Temp

20 0

20 0

n actured by SAMSUNG ELECTRONICS C	ECTRONICS C	Table : (projection based	Table 2: Interpolation Report (projection based on <i>in-sit</i> u temperature entered)
		T _{s,1} (°C)	92.00
		T _{s,1} (K)	328.15
Test Condition 3 - 105°C Case Temp	C Case Temp	αı	7.159E-06
Sample size	20	В,	1.017
Number of failures	0	T _{s,2} (°C)	00'58
DUT drive current used in the test (mA)	150	T _{s,2} (K)	358.15
Test duration (hours)	10,000	\mathfrak{a}_2	7.253E-06
Test duration used for projection (hour to hour)	5,000 - 10,000	B ₂	1.008
Tested case temperature (°C)	105	E _a /k _b	5.09E+01
ø	1.102E-05	Ą	8.359E-06
a	1.009	B ₀	1.013
Calculated L70(10k) (hours)	33,000	T _{s,i} (⁰ C)	73.50
Reported L70(10k)	33,000	T _{s,i} (K)	346.65
i de	P.	ਲੌ	7.219E-06
		Projected L70(10k) at 73.5°C (hours)	000'19
		Reported L70(10k) at 73.5°C (hours)	51,000

10,000

150

DUT drive current used in the test (mA) Fest duration (hours)

150

OUT drive current used n the test (mA) est duration (hours)

Jumber of failures

Sample size

10,000

Number of failures Sample size

Test duration used for 5,000 - 10,000 projection (hour to hour)

Test duration used for 5,000 - 10,000 projection (hour to hour)

50,000 50,000

Calculated L70(10k) Reported L70(10k)

hours)

52,000

alculated L70(10k) Reported L70(10k)

hours)

52,000

7.253E-06 1.008

7.159E-06 1.017

55

ested case temperature

82

ested case temperature

Notes: N.A		
Report Generated By: Bowen Pang	Company: LCTECH (Zhongshan) Testing Service Co.,Ltd.	Date:Sep. 22. 2016

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****End of test report****